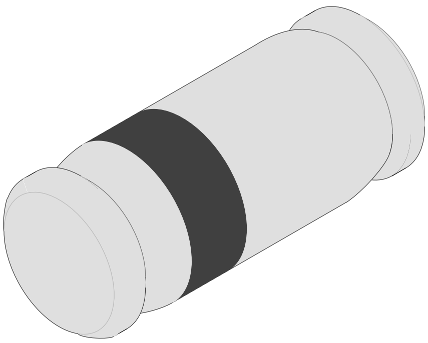
Silicon Epitaxial Planar Z–Diodes

Features

- Very sharp reverse characteristic
- Low reverse current level
- Available with tighter tolerances
- Very high stability
- Low noise



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Applications

Voltage stabilization

Order Instruction

Type	Ordering Code	Remarks
TZMC2V4	TZMC2V4–GS08	Tape and Reel (2.500 pcs)
	TZMC2V4–GS18	Tape and Reel (10.000 pcs)

Absolute Maximum Ratings

T_j = 25°C

Parameter	Test Conditions	Type	Symbol	Value	Unit
Power dissipation	$R_{thJA} \leqq 300 K/W$		P_V	500	mW
Z–current			I_Z	P_V/V_Z	mA
Junction temperature			T_j	175	°C
Storage temperature range			T_{stg}	–65...+175	°C

Maximum Thermal Resistance

T_j = 25°C

Parameter	Test Conditions	Symbol	Value	Unit
Junction ambient	on PC board 50 mmx50 mmx1.6 mm	R_{thJA}	500	K/W

Electrical Characteristics

T_j = 25°C

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Forward voltage	I_F=200mA		V_F			1.5	V

Type	V_{Znom}	I_{ZT} for V_{ZT} and r_{zjT}			r_{zjk} at I_{ZK}		I_R and I_R at V_R			TK_{VZ}
TZMC...	V	mA	V[1)]	Ω	Ω	mA	µA	µA [2)]	V	%/K
2V4	2.4	5	2.28 to 2.56	< 85	< 600	1	< 50	< 100	1	–0.09 to –0.06
2V7	2.7	5	2.5 to 2.9	< 85	< 600	1	< 10	< 50	1	–0.09 to –0.06
3V0	3.0	5	2.8 to 3.2	< 90	< 600	1	< 4	< 40	1	–0.08 to –0.05
3V3	3.3	5	3.1 to 3.5	< 90	< 600	1	< 2	< 40	1	–0.08 to –0.05
3V6	3.6	5	3.4 to 3.8	< 90	< 600	1	< 2	< 40	1	–0.08 to –0.05
3V9	3.9	5	3.7 to 4.1	< 90	< 600	1	< 2	< 40	1	–0.08 to –0.05
4V3	4.3	5	4.0 to 4.6	< 90	< 600	1	< 1	< 20	1	–0.06 to –0.03
4V7	4.7	5	4.4 to 5.0	< 80	< 600	1	< 0.5	< 10	1	–0.05 to +0.02
5V1	5.1	5	4.8 to 5.4	< 60	< 550	1	< 0.1	< 2	1	–0.02 to +0.02
5V6	5.6	5	5.2 to 6.0	< 40	< 450	1	< 0.1	< 2	1	–0.05 to +0.05
6V2	6.2	5	5.8 to 6.6	< 10	< 200	1	< 0.1	< 2	2	0.03 to 0.06
6V8	6.8	5	6.4 to 7.2	< 8	< 150	1	< 0.1	< 2	3	0.03 to 0.07
7V5	7.5	5	7.0 to 7.9	< 7	< 50	1	< 0.1	< 2	5	0.03 to 0.07
8V2	8.2	5	7.7 to 8.7	< 7	< 50	1	< 0.1	< 2	6.2	0.03 to 0.08
9V1	9.1	5	8.5 to 9.6	< 10	< 50	1	< 0.1	< 2	6.8	0.03 to 0.09
10	10	5	9.4 to 10.6	< 15	< 70	1	< 0.1	< 2	7.5	0.03 to 0.1
11	11	5	10.4 to 11.6	< 20	< 70	1	< 0.1	< 2	8.2	0.03 to 0.11
12	12	5	11.4 to 12.7	< 20	< 90	1	< 0.1	< 2	9.1	0.03 to 0.11
13	13	5	12.4 to 14.1	< 26	< 110	1	< 0.1	< 2	10	0.03 to 0.11
15	15	5	13.8 to 15.6	< 30	< 110	1	< 0.1	< 2	11	0.03 to 0.11
16	16	5	15.3 to 17.1	< 40	< 170	1	< 0.1	< 2	12	0.03 to 0.11
18	18	5	16.8 to 19.1	< 50	< 170	1	< 0.1	< 2	13	0.03 to 0.11
20	20	5	18.8 to 21.2	< 55	< 220	1	< 0.1	< 2	15	0.03 to 0.11
22	22	5	20.8 to 23.3	< 55	< 220	1	< 0.1	< 2	16	0.04 to 0.12
24	24	5	22.8 to 25.6	< 80	< 220	1	< 0.1	< 2	18	0.04 to 0,12
27	27	5	25.1 to 28.9	< 80	< 220	1	< 0.1	< 2	20	0.04 to 0.12
30	30	5	28 to 32	< 80	< 220	1	< 0.1	< 2	22	0.04 to 0.12
33	33	5	31 to 35	< 80	< 220	1	< 0.1	< 2	24	0.04 to 0.12
36	36	5	34 to 38	< 80	< 220	1	< 0.1	< 2	27	0.04 to 0.12
39	39	2.5	37 to 41	< 90	< 500	0.5	< 0.1	< 5	30	0.04 to 0.12
43	43	2.5	40 to 46	< 90	< 600	0.5	< 0.1	< 5	33	0.04 to 0.12
47	47	2.5	44 to 50	< 110	< 700	0.5	< 0.1	< 5	36	0.04 to 0.12
51	51	2.5	48 to 54	< 125	< 700	0.5	< 0.1	< 10	39	0.04 to 0.12
56	56	2.5	52 to 60	< 135	< 1000	0.5	< 0.1	< 10	43	0.04 to 0.12
62	62	2.5	58 to 66	< 150	< 1000	0.5	< 0.1	< 10	47	0.04 to 0.12
68	68	2.5	64 to 72	< 200	< 1000	0.5	< 0.1	< 10	51	0.04 to 0.12
75	75	2.5	70 to 79	< 250	< 1500	0.5	< 0.1	< 10	56	0.04 to 0.12

[1)] Tighter tolerances available on request:
TZMA... ± 1% of V_{Znom} TZMB... ± 2% of V_{Znom} TZMF... ± 3% of V_{Znom}
[2)] at T_j= 150°C

Characteristics (T$_j$ = 25°C unless otherwise specified)

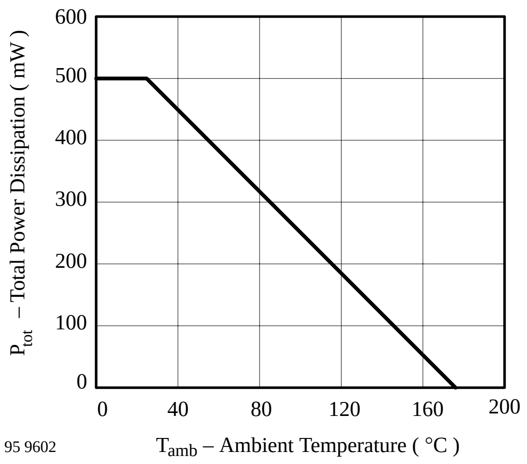


Figure 1. Total Power Dissipation vs. Ambient Temperature

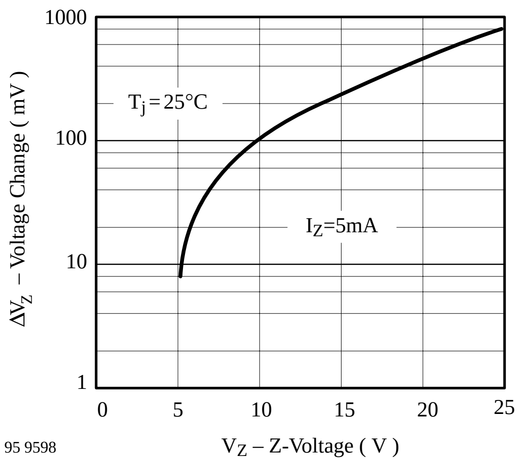


Figure 2. Typical Change of Working Voltage under Operating Conditions at T$_{amb}$=25°C

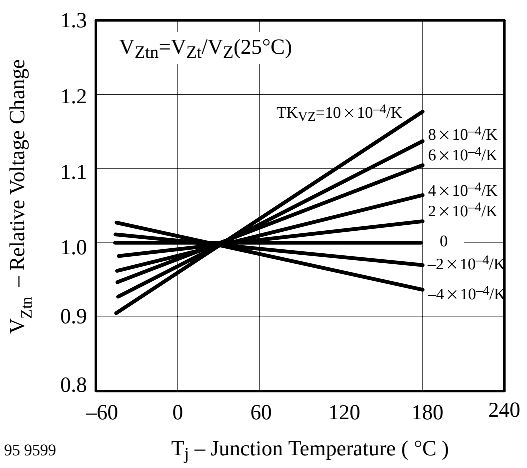


Figure 3. Typical Change of Working Voltage vs. Junction Temperature

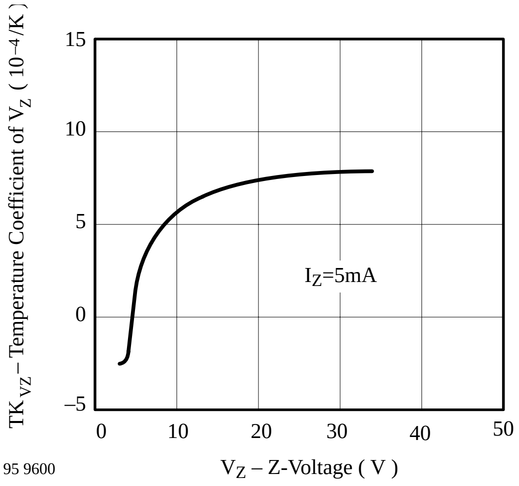


Figure 4. Temperature Coefficient of Vz vs. Z–Voltage

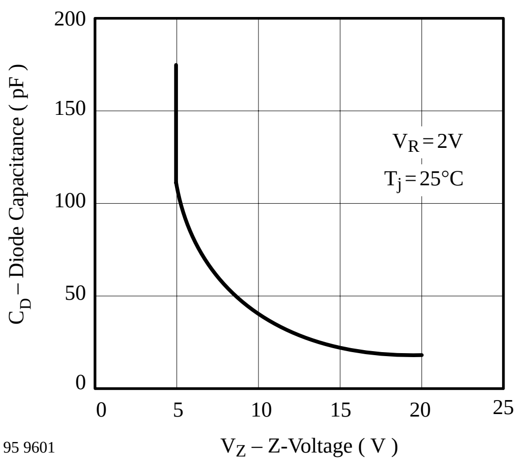


Figure 5. Diode Capacitance vs. Z–Voltage

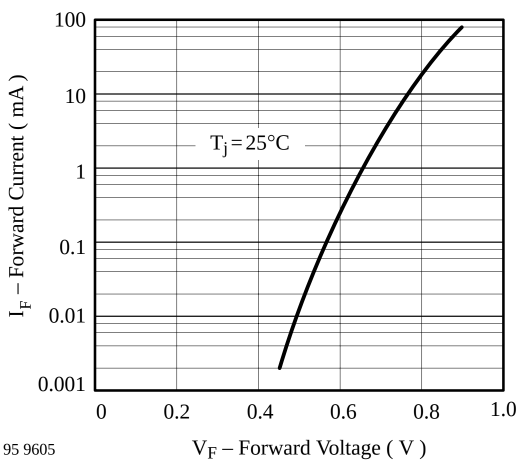


Figure 6. Forward Current vs. Forward Voltage

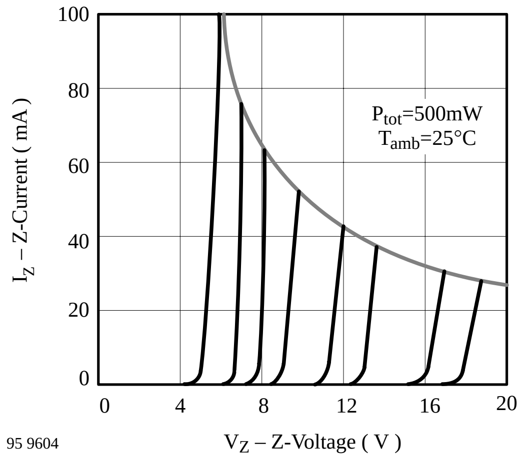


Figure 7. Z–Current vs. Z–Voltage

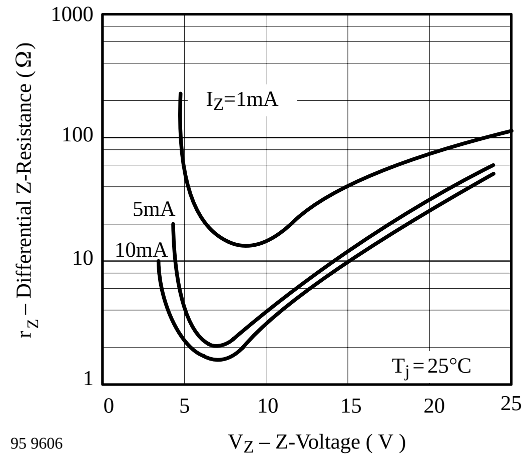


Figure 9. Differential Z–Resistance vs. Z–Voltage

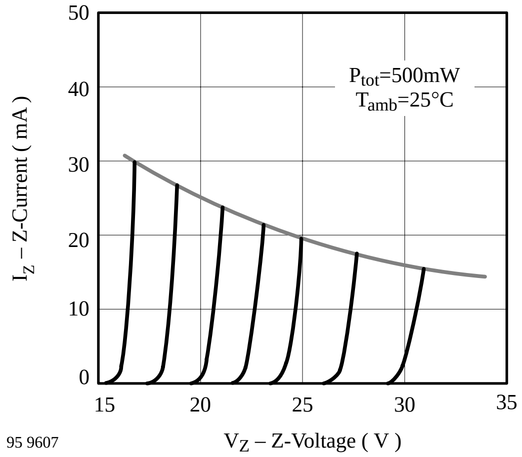


Figure 8. Z–Current vs. Z–Voltage

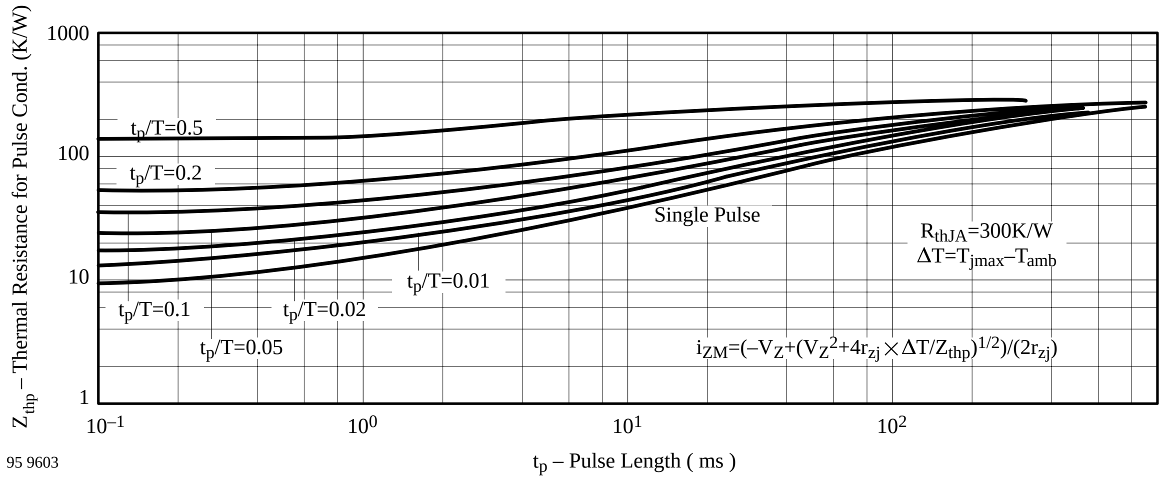
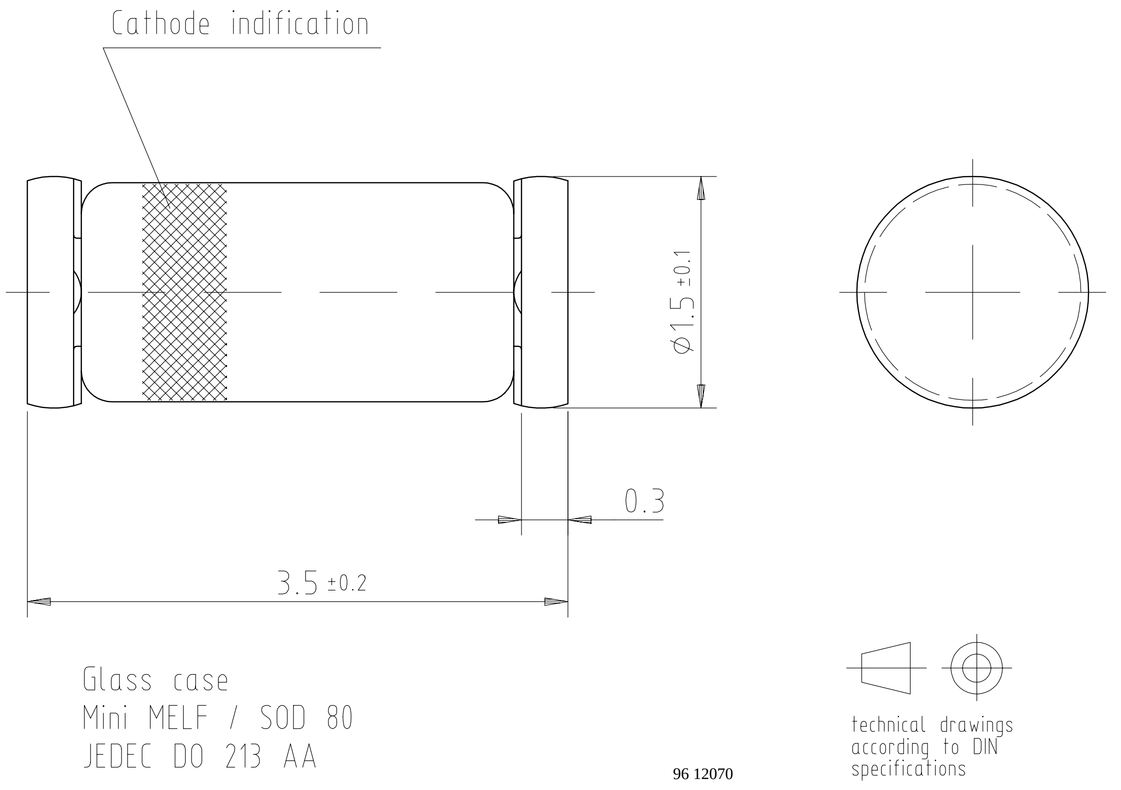


Figure 10. Thermal Response

Dimensions in mm



Ozone Depleting Substances Policy Statement

It is the policy of **Vishay Semiconductor GmbH** to

1. Meet all present and future national and international statutory requirements.

2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively

2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA

3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

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